life.augmented

TO-220FP

ultra narrow leads

D(2) $_{\bigcirc}$

് S(3)

Figure 1: Internal schematic diagram

G(1) O

STFU10NK60Z

N-channel 600 V, 0.68 Ω typ., 10 A, SuperMESH™ Power MOSFET in a TO-220FP ultra narrow leads package

Datasheet - production data



Order code	VDS	RDS(on) max.	ID	Ptot
STFU10NK60Z	600 V	0.75 Ω	10 A	35 W

- Extremely high dv/dt capability
- 100% avalanche tested
- Gate charge minimized
- Zener-protected

Applications

• Switching applications

Description

This high voltage device is a Zener-protected N-channel Power MOSFET developed using the SuperMESH[™] technology by STMicroelectronics, an optimization of the well-established PowerMESH[™]. In addition to a significant reduction in on-resistance, this device is designed to ensure a high level of dv/dt capability for the most demanding applications.

Table 1: Device summary

SC15010

Order code	Marking	Package	Packaging
STFU10NK60Z	10NK60Z	TO-220FP ultra narrow leads	Tube

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This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
VDS	Drain-source voltage	600	V
V _{GS}	Gate-source voltage	±30	V
I _D ⁽¹⁾	Drain current (continuous) at Tc= 25 °C	10	А
ID ⁽¹⁾	Drain current (continuous) at T _c = 100 °C	5.7	А
I _{DM} ⁽²⁾	Drain current (pulsed)	36	А
Ртот	Total dissipation at $T_C = 25 \text{ °C}$	35	W
ESD	Gate-source, human body model (R = $1.5 \text{ k}\Omega$, C = 100 pF)	4	kV
dv/dt ⁽³⁾	Peak diode recovery voltage slope	4.5	V/ns
Viso	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1s; T_c = 25 °C) 250		V
Tj	Operation junction temperature range	55 to 150	°C
T _{stg}	Storage temperature range	-55 to 150	U

Notes:

⁽¹⁾Limited by package

 $\ensuremath{^{(2)}}\ensuremath{\mathsf{Pulse}}$ width limited by safe operating area

 $^{(3)}I_{SD}$ < 10 A , di/dt < 200 A/µs , V_DD = 80 % V_{(BR)DSS}

Table 3: Thermal data

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	3.6	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
lar	Avalanche current, repetitive or non-repetitive (pulse width limited by $T_{\rm J}$ max)	10	А
E _{AS}	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$, $I_D = I_{AR}$, $V_{DD} = 50 \text{ V}$)	300	mJ



2 Electrical characteristics

(T_c = 25 °C unless otherwise specified)

Table 5: On /on states								
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS}=0~V,~I_D=250~\mu A$	600			V		
I _{DSS} Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 600 V$			1	μA			
	o o	$V_{GS} = 0 V, V_{DS} = 600 V,$ $T_{C} = 125 \ ^{\circ}C^{(1)}$			50	μΑ		
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 V, V_{GS} = +20 V$			±10	μA		
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	3	3.75	4.5	V		
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10 \ V, \ I_D = 4.5 \ A$		0.68	0.75	Ω		

Table 5: On /off states

Notes:

 $^{(1)}\mbox{Defined}$ by design, not subject to production test.

I able 6: Dynamic								
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
Ciss	Input capacitance		-	1370	-	pF		
Coss	Output capacitance	V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz	-	156	-	pF		
Crss	Reverse transfer capacitance		-	37	-	pF		
Coss eq ⁽¹⁾	Equivalent output capacitance	$V_{\text{GS}}\text{=}$ 0 V, $V_{\text{DS}}\text{=}$ 0 to 480 V	-	93	-	pF		
Qg	Total gate charge	$V_{DD} = 480 V, I_D = 8 A,$	-	48	-	nC		
Qgs	Gate-source charge	$V_{GS} = 10 V$	-	8	-	nC		
Q _{gd}	Gate-drain charge	(see Figure 13: "Test circuit for gate charge behavior")	-	25	-	nC		

Table 6: Dynamic

Notes:

 $^{(1)}C_{oss\ eq}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80%

Table	7:	Switching	times
IUNIC	•••	omitoring	

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
td(on)	Turn-on delay time	$V_{DD} = 300 V, I_D = 4 A,$	-	20	-	ns
tr	Rise time	$R_G = 4.7 \ \Omega, V_{GS} = 10 \ V$	-	20	-	ns
td(off)	Turn-off delay time	(see Figure 12: "Test circuit for resistive load switching	-	55	-	ns
tr	Fall time	times" and Figure 17: "Switching time waveform")	-	30	-	ns



Electrical characteristics

	Table 8: Source drain diode								
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit			
I _{SD} ⁽¹⁾	Source-drain current		-		10	V			
I _{SDM} ⁽²⁾	Source-drain current (pulsed)		-		36	А			
Vsd ⁽³⁾	Forward on voltage	$I_{SD}= 10 \text{ A}, V_{GS}= 0 \text{ V}$	-		1.6	V			
trr	Reverse recovery time	$I_{SD} = 8 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	570		ns			
Qrr	Reverse recovery charge	$V_{DD} = 40 \text{ V}$, $T_J = 150 \text{ °C}$	-	4.1		μC			
Irrm	Reverse recovery current	(see Figure 14: "Test circuit for inductive load switching and diode recovery times")	-	15		A			

Notes:

⁽¹⁾Limited by package

⁽²⁾Pulse width limited by safe operating area

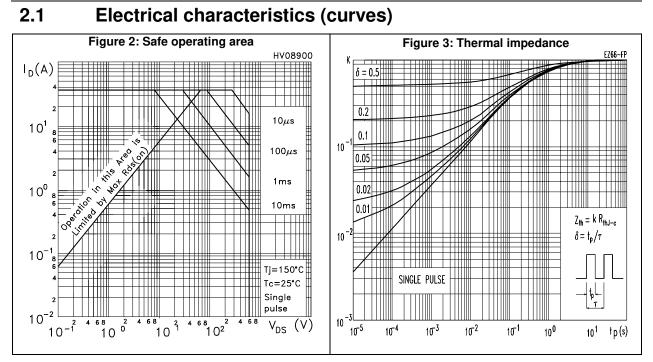
 $^{(3)}\text{Pulsed:}$ pulse duration = 300 $\mu\text{s},$ duty cycle 1.5%

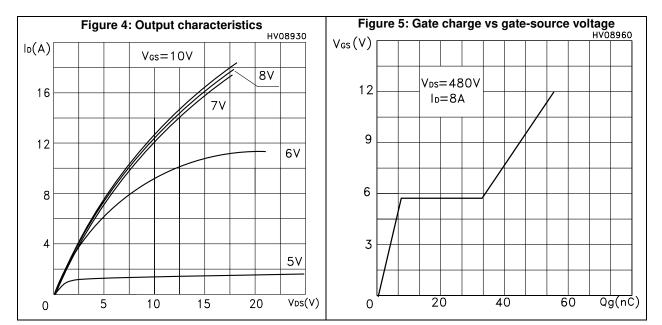
Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V(BR)GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



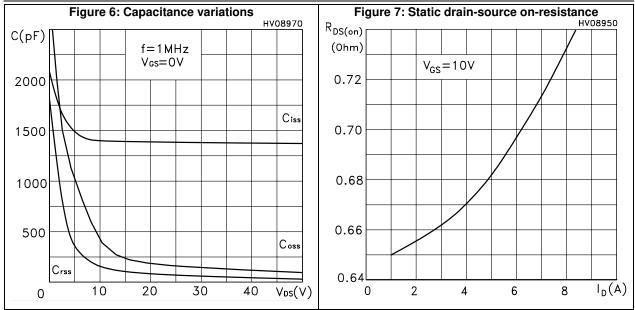


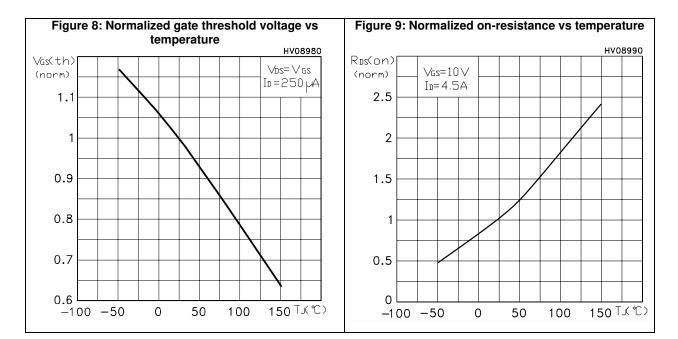




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Electrical characteristics

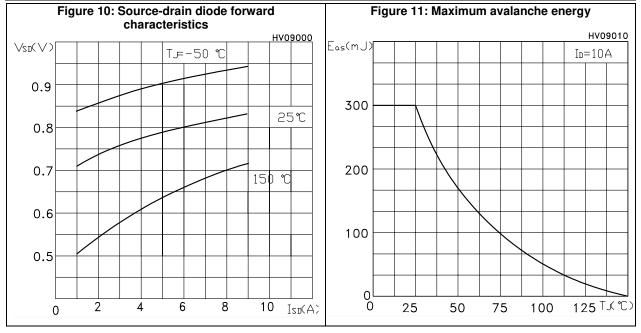






Electrical characteristics

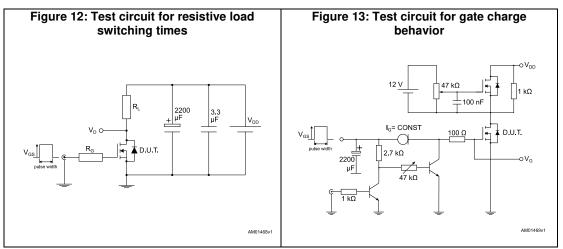
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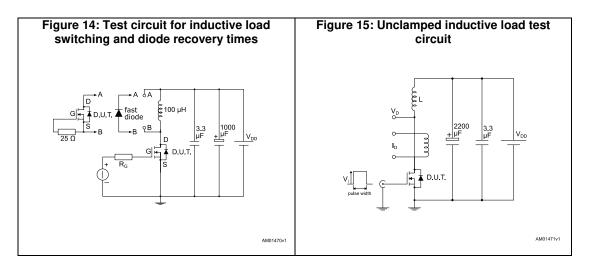


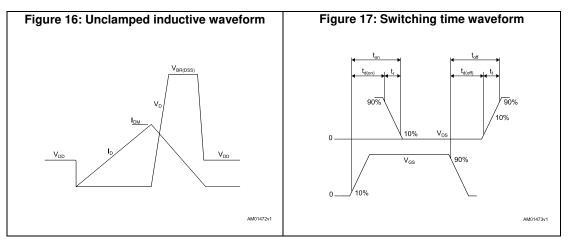
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3 Test circuits









4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

4.1 TO-220FP ultra narrow leads package information

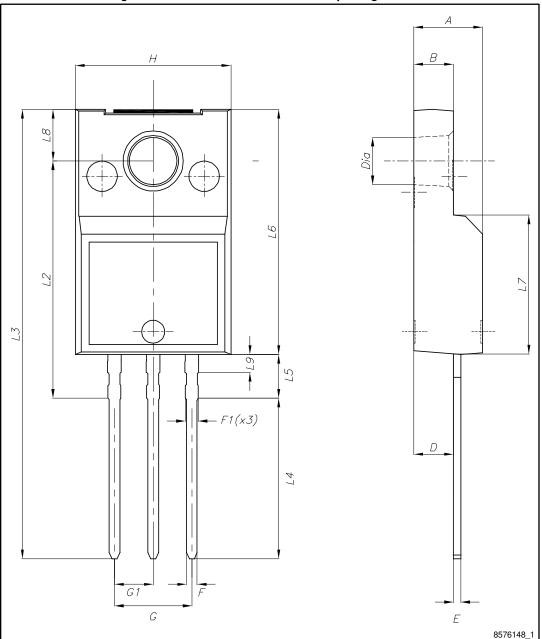
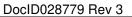


Figure 18: TO-220FP ultra narrow leads package outline





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<60Z			Package information	
Table 10: TO-220FP ultra narrow leads mechanical data				
Dim.	mm			
	Min.	Тур.	Max.	
Α	4.40		4.60	
В	2.50		2.70	
D	2.50		2.75	
E	0.45		0.60	
F	0.65		0.75	
F1	-		0.90	
G	4.95		5.20	
G1	2.40	2.54	2.70	
Н	10.00		10.40	
L2	15.10		15.90	
L3	28.50		30.50	
L4	10.20		11.00	
L5	2.50		3.10	
L6	15.60		16.40	
L7	9.00		9.30	
L8	3.20		3.60	
L9	-		1.30	
Dia.	3.00		3.20	



Revision history 5

Table 11: Document revision history

Date	Revision	Changes
07-Jan-2016	1	Initial release.
12-Sep-2016	2	Document status changed from preliminary to production data. Minor text changes.
05-Dec-2016	3	Updated Features on cover page. Updated <i>Table 2: "Absolute maximum ratings"</i> and added <i>Table 4: "Avalanche characteristics".</i> Updated <i>Table 5: "On /off states", Table 6: "Dynamic", Table 8: "Source drain diode"</i> and <i>Table 9: "Gate-source Zener diode".</i> Minor text changes



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